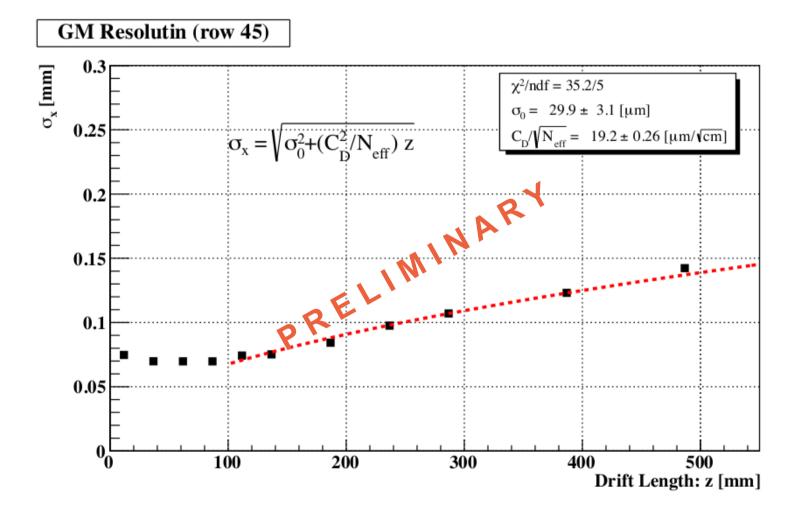
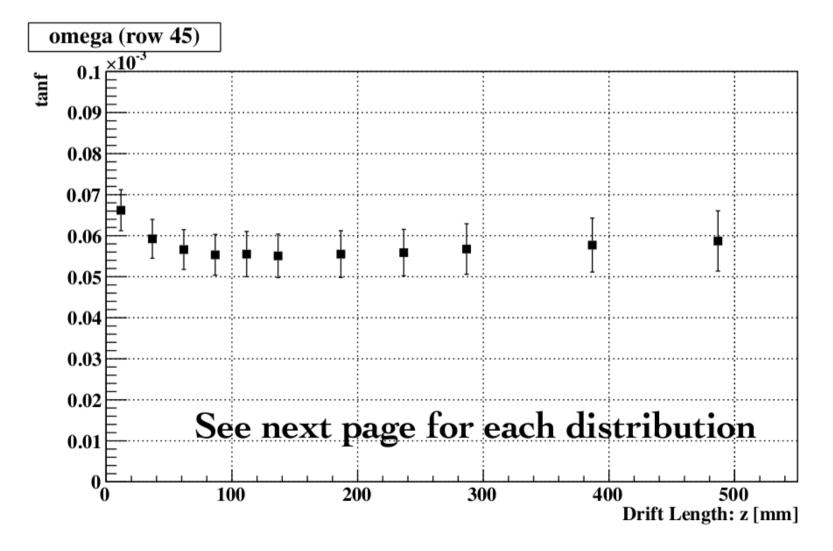
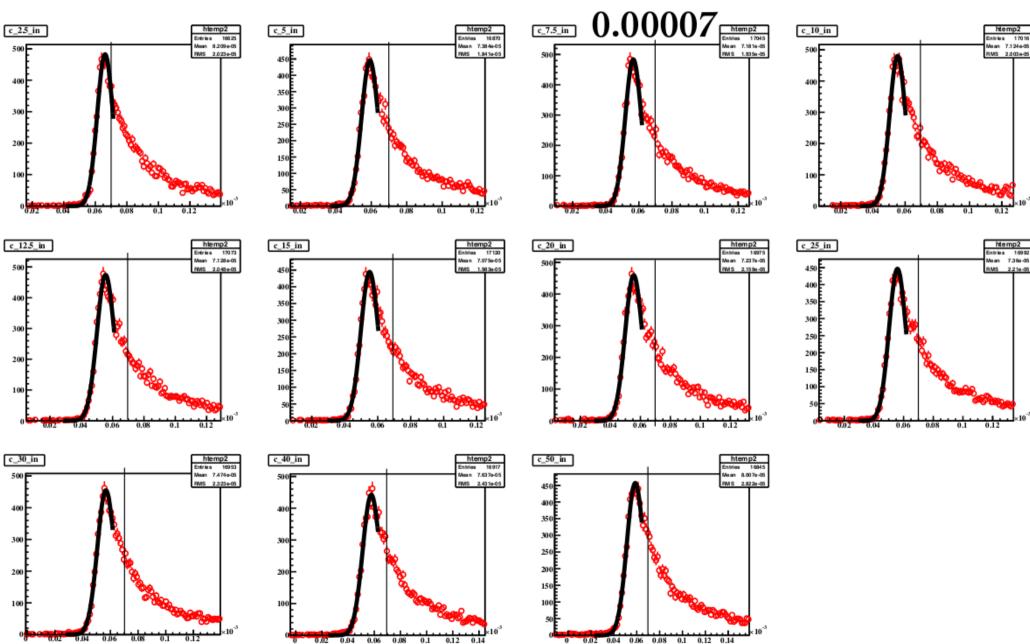
Status of test beam data analysis (analysis by Ryo)

Cuts: ntrks=1, ndf>=100, omega < 0.00007, omega>0.00002



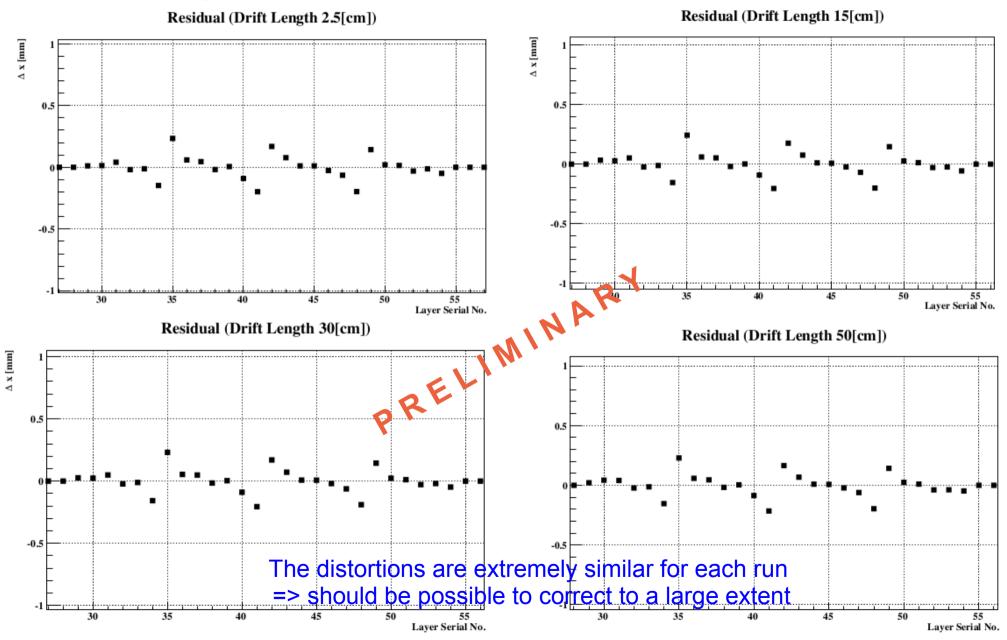
Cuts: ntrks=1, ndf>=100





Cuts: ntrks=1, ndf>=100

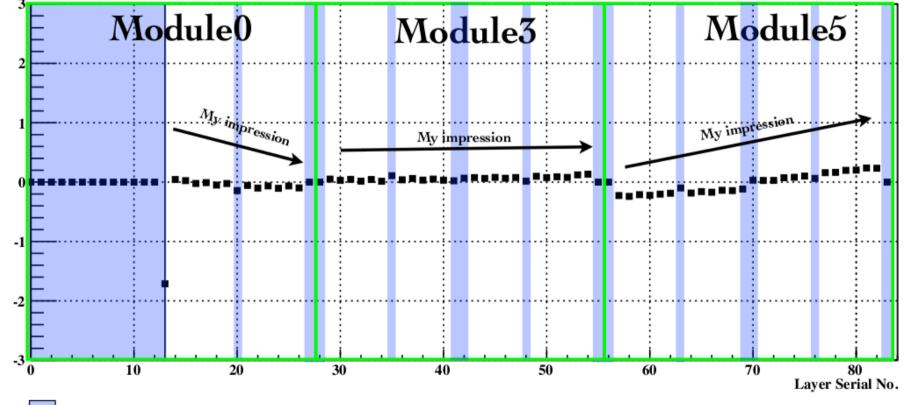
Cuts: ntrks=1, ndf>=100, omega < 0.00007, omega>0.00002



Residual in 0T from Asian GEM Data

Systematical displacement?





: Problematic pad-rows (e.g. affected by electrical distortion)

2013 in Japan

- Finish test box for 2 modules + laser
 - test of edge effects
- Test wire gate
- Work on SALTRO16 module
 - new pad board with possibility to make adaptors for ALTRO (with MCM shape)
 - Cooling system for SALTRO electronics